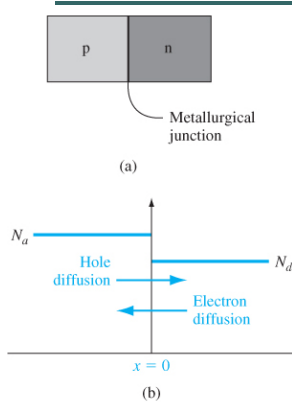


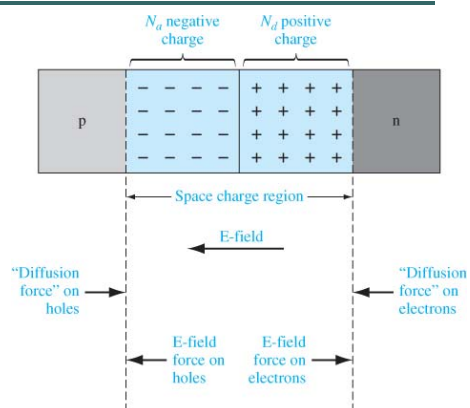
*EE415/515 Fundamentals  
of Semiconductor Devices  
Fall 2012*

**Lecture 7:  
PN Junction  
(Chapter 7)**

Introduction



**Figure 7.1** | (a) Simplified geometry of a pn junction; (b) doping profile of an ideal uniformly doped pn junction.



**Figure 7.2** | The space charge region, the electric field, and the forces acting on the charged carriers.

## Built-in Potential Barrier

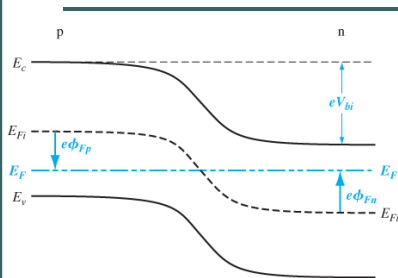


Figure 7.3 | Energy-band diagram of a pn junction in thermal equilibrium.

Define potentials  $\phi_{Fn}$  and  $\phi_{Fp}$  as shown, so

$$V_{bi} = |\phi_{Fn}| + |\phi_{Fp}|$$

In n - region  $n_0 = N_c \exp\left(-\frac{E_c - E_F}{kT}\right) = n_i \exp\left(\frac{E_F - E_{Fi}}{kT}\right)$

so  $e\phi_{Fn} = E_{Fi} - E_F = kT \ln \frac{n_i}{n_0} \Rightarrow \phi_{Fn} = -\frac{kT}{e} \ln \frac{N_d}{n_i}$

and similarly

$$p_0 = N_a = n_i \exp\left(\frac{E_{Fi} - E_F}{kT}\right) \Rightarrow \phi_{Fp} = +\frac{kT}{e} \ln \frac{N_a}{n_i}$$

$$\therefore V_{bi} = \frac{kT}{e} \ln \frac{N_d}{n_i} + \frac{kT}{e} \ln \frac{N_a}{n_i} = \frac{kT}{e} \ln \frac{N_a N_d}{n_i^2}$$

Note :

$N_d, N_a$  are NET doping in n-, p - regions respectively

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3

- Ex 7.1 (a) Calculate  $V_{bi}$  for a Si pn junction at 300K for:  
 (i)  $N_a = 5 \times 10^{15} \text{cm}^{-3}$ ,  $N_d = 10^{17} \text{cm}^{-3}$  and (ii)  $N_a = 2 \times 10^{16} \text{cm}^{-3}$ ,  $N_d = 2 \times 10^{15} \text{cm}^{-3}$   
 (b) Repeat (a) for GaAs

$$(a) V_{bi} = V_T \ln \left( \frac{N_a N_d}{n_i^2} \right)$$

$$(i) V_{bi} = (0.0259) \ln \left[ \frac{(5 \times 10^{15})(10^{17})}{(1.5 \times 10^{10})^2} \right] = 0.736 \text{V}$$

$$(ii) V_{bi} = (0.0259) \ln \left[ \frac{(2 \times 10^{16})(2 \times 10^{15})}{(1.5 \times 10^{10})^2} \right] = 0.671 \text{V}$$

(b)

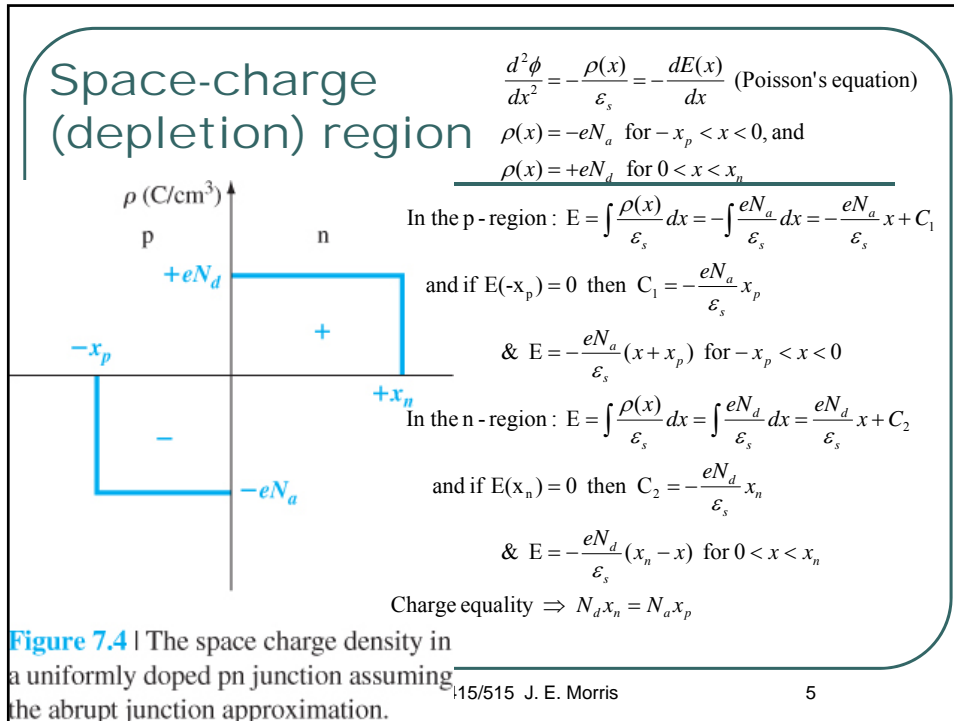
$$(i) V_{bi} = (0.0259) \ln \left[ \frac{(5 \times 10^{15})(10^{17})}{(1.8 \times 10^6)^2} \right] = 1.20 \text{V}$$

$$(ii) V_{bi} = (0.0259) \ln \left[ \frac{(2 \times 10^{16})(2 \times 10^{15})}{(1.8 \times 10^6)^2} \right] = 1.14 \text{V}$$

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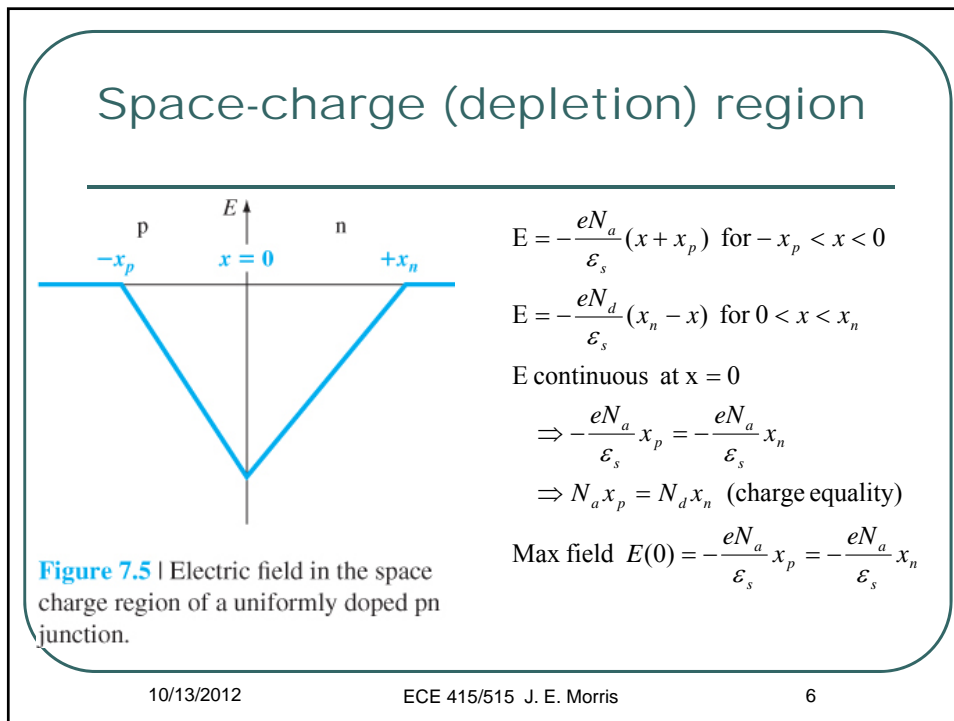
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5



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6

# Space-charge (depletion) region

$$E = -\frac{eN_a}{\epsilon_s}(x+x_p) \text{ for } -x_p < x < 0$$

$$E = -\frac{eN_d}{\epsilon_s}(x_n-x) \text{ for } 0 < x < x_n$$

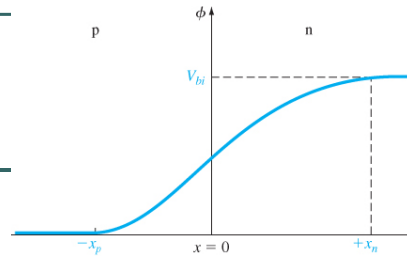


Figure 7.6 | Electric potential through the space charge region of a uniformly doped pn junction.

For the p-region :  $\phi(x) = -\int E(x)dx = \int \frac{eN_a}{\epsilon_s}(x+x_p) dx = \frac{eN_a}{\epsilon_s}(\frac{x^2}{2} + x_p x) + C'_1$

Set  $\phi(-x_p) = 0$ , so  $C'_1 = \frac{eN_a}{\epsilon_s} \cdot \frac{x_p^2}{2}$  &  $\phi(x) = \frac{eN_a}{2\epsilon_s}(x+x_p)^2$

For the n-region :  $\phi(x) = -\int E(x)dx = \int \frac{eN_d}{\epsilon_s}(x_n-x) dx = \frac{eN_d}{\epsilon_s}(x_n x - \frac{x^2}{2}) + C'_2$

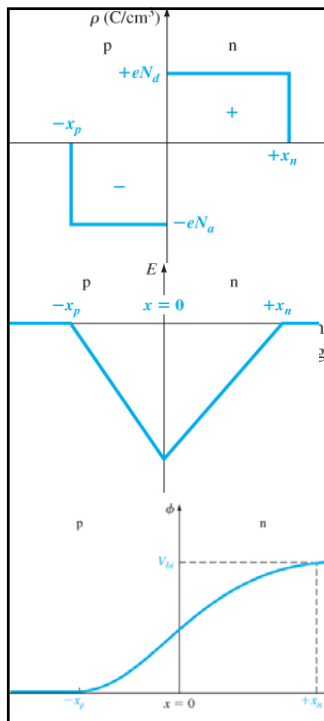
Now  $\phi(0_n) = \phi(0_p)$ , so  $C'_2 = \frac{eN_a}{2\epsilon_s} x_p^2$  &  $\phi(x) = \frac{eN_d}{\epsilon_s}(x_n x - \frac{x^2}{2}) + \frac{eN_a}{2\epsilon_s} x_p^2$

Since  $\phi(-x_p) = 0$ ,  $V_{bi} = \phi(x_n) = \frac{eN_d}{2\epsilon_s} x_n^2 + \frac{eN_a}{2\epsilon_s} x_p^2$

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7



$N_a x_p = N_d x_n$  (charge equality) &  $\frac{d^2 \phi}{dx^2} = -\frac{\rho(x)}{\epsilon_s} = -\frac{dE(x)}{dx}$

$\rho(x) = -eN_a$  for  $-x_p < x < 0$ , and  $\rho(x) = +eN_d$  for  $0 < x < x_n$

In the p-region :  $E = \int \frac{\rho(x)}{\epsilon_s} dx = -\int \frac{eN_a}{\epsilon_s} dx = -\frac{eN_a}{\epsilon_s} x + C_1$

and  $E(-x_p) = 0 \Rightarrow C_1 = -\frac{eN_a}{\epsilon_s} x_p$  &  $E = -\frac{eN_a}{\epsilon_s}(x+x_p)$  for  $-x_p < x < 0$

In the n-region :  $E = \int \frac{\rho(x)}{\epsilon_s} dx = \int \frac{eN_d}{\epsilon_s} dx = \frac{eN_d}{\epsilon_s} x + C_2$

and  $E(x_n) = 0 \Rightarrow C_2 = -\frac{eN_d}{\epsilon_s} x_n$  &  $E = -\frac{eN_d}{\epsilon_s}(x_n-x)$  for  $0 < x < x_n$

$E_{max} = -\frac{eN_a}{\epsilon_s} x_p = -\frac{eN_d}{\epsilon_s} x_n$  at  $x = 0$

For the p-region :  $\phi(x) = -\int E(x)dx = \int \frac{eN_a}{\epsilon_s}(x+x_p) dx = \frac{eN_a}{\epsilon_s}(\frac{x^2}{2} + x_p x) + C'_1$

Set  $\phi(-x_p) = 0$ , so  $C'_1 = \frac{eN_a}{\epsilon_s} \cdot \frac{x_p^2}{2}$  &  $\phi(x) = \frac{eN_a}{2\epsilon_s}(x+x_p)^2$

For the n-region :  $\phi(x) = -\int E(x)dx = \int \frac{eN_d}{\epsilon_s}(x_n-x) dx = \frac{eN_d}{\epsilon_s}(x_n x - \frac{x^2}{2}) + C'_2$

Now  $\phi(0_n) = \phi(0_p)$ , so  $C'_2 = \frac{eN_a}{2\epsilon_s} x_p^2$  &  $\phi(x) = \frac{eN_d}{\epsilon_s}(x_n x - \frac{x^2}{2}) + \frac{eN_a}{2\epsilon_s} x_p^2$

Since  $\phi(-x_p) = 0$ ,  $V_{bi} = \phi(x_n) = \frac{eN_d}{2\epsilon_s} x_n^2 + \frac{eN_a}{2\epsilon_s} x_p^2$

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8

## Space-charge region width

$$V_{bi} = \phi(x_n) = \frac{eN_d}{2\epsilon_s} x_n^2 + \frac{eN_a}{2\epsilon_s} x_p^2 \text{ and } N_a x_p = N_d x_n$$

$$\text{Substitute } x_p = \frac{N_d x_n}{N_a} \Rightarrow V_{bi} = \frac{eN_d}{2\epsilon_s} x_n^2 + \frac{eN_a}{2\epsilon_s} \left( \frac{N_d x_n}{N_a} \right)^2 = \frac{e}{2\epsilon_s} \left[ N_d + \frac{N_d^2}{N_a} \right] x_n^2 = \frac{e}{2\epsilon_s} \cdot \frac{N_d}{N_a} [N_a + N_d] x_n^2$$

$$\text{so } x_n = \sqrt{\frac{2\epsilon_s V_{bi}}{e} \cdot \frac{N_a}{N_d} \cdot \frac{1}{[N_a + N_d]}}$$

$$\text{Substitute } x_n = \frac{N_a x_p}{N_d} \Rightarrow V_{bi} = \frac{eN_a}{2\epsilon_s} x_p^2 + \frac{eN_d}{2\epsilon_s} \left( \frac{N_a x_p}{N_d} \right)^2 = \frac{e}{2\epsilon_s} \left[ N_a + \frac{N_a^2}{N_d} \right] x_p^2 = \frac{e}{2\epsilon_s} \cdot \frac{N_a}{N_d} [N_a + N_d] x_p^2$$

$$\text{so } x_p = \sqrt{\frac{2\epsilon_s V_{bi}}{e} \cdot \frac{N_d}{N_a} \cdot \frac{1}{[N_a + N_d]}}$$

$$\text{and } W = x_n + x_p \text{ so } W = \sqrt{\frac{2\epsilon_s V_{bi}}{e} \cdot \frac{1}{[N_a + N_d]}} \left[ \sqrt{\frac{N_d}{N_a}} + \sqrt{\frac{N_a}{N_d}} \right] = \sqrt{\frac{2\epsilon_s V_{bi}}{e} \cdot \frac{1}{[N_a + N_d]} \cdot \frac{N_a + N_d}{\sqrt{N_a N_d}}}$$

$$W = \sqrt{\frac{2\epsilon_s V_{bi}}{e} \cdot \frac{(N_a + N_d)}{N_a N_d}}$$

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9

Ex 7.2 Si pn junction at 300K with zero applied bias has  $N_d = 5 \times 10^{16} / \text{cm}^3$  and  $N_a = 5 \times 10^{15} / \text{cm}^3$ . Find  $x_n$ ,  $x_p$ ,  $W$ ,  $|E_{\max}|$ .

$$V_{bi} = V_T \ln \left( \frac{N_a N_d}{n_i^2} \right) = (0.0259) \ln \left[ \frac{(5 \times 10^{16})(5 \times 10^{15})}{(1.5 \times 10^{10})^2} \right] = 0.7184 \text{ V}$$

Then

$$x_n = \left[ \frac{2\epsilon_s V_{bi}}{e} \left( \frac{N_a}{N_d} \right) \left( \frac{1}{N_a + N_d} \right) \right]^{1/2} = \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184)}{(1.6 \times 10^{-19})} \times \left( \frac{5 \times 10^{15}}{5 \times 10^{16}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2}$$

$$\Rightarrow x_n = 4.11 \times 10^{-6} \text{ cm}$$

$$x_p = \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184)}{(1.6 \times 10^{-19})} \times \left( \frac{5 \times 10^{16}}{5 \times 10^{15}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2}$$

$$\Rightarrow x_p = 4.11 \times 10^{-6} \text{ cm}$$

$$\text{Now } W = x_n + x_p = 4.11 \times 10^{-6} + 4.11 \times 10^{-6} = 8.22 \times 10^{-6} \text{ cm}$$

$$\text{Now } |E_{\max}| = \frac{eV_{bi} x_n}{\epsilon_s} = \frac{(1.6 \times 10^{-19})(5 \times 10^{16})(4.11 \times 10^{-6})}{(11.7)(8.85 \times 10^{-14})} = 3.18 \times 10^4 \text{ V/cm}$$

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10

**Figure 7.7** | Energy-band diagram of a pn junction under reverse bias.

## Reverse bias

$$V_{total} = |\phi_{Fn}| + |\phi_{Fp}| + V_R = V_{bi} + V_R$$

$$W \Rightarrow \sqrt{\frac{2\epsilon_s(V_{bi} + V_R)}{e} \cdot \frac{(N_a + N_d)}{N_a N_d}}$$

$$E_{max} = -\frac{eN_d x_n}{\epsilon_s} = -\frac{eN_a x_p}{\epsilon_s}$$

$$= -\sqrt{\frac{2e(V_{bi} + V_R)}{\epsilon_s} \cdot \frac{N_a N_d}{(N_a + N_d)}}$$

$$= -2 \frac{V_{bi} + V_R}{W}$$

**Figure 7.8** | A pn junction, with an applied reverse-biased voltage, showing the directions of the electric field induced by VR and the space charge electric field.

515 J. E. Morris 11

Ex 7.3 Si pn junction at 300K has  $N_d = 5 \times 10^{16}/\text{cm}^3$  and  $N_a = 5 \times 10^{15}/\text{cm}^3$ . Find  $V_{bi}$ ,  $x_n$ ,  $x_p$ , and  $W$  for reverse bias (a)  $V_R = 4\text{V}$  & (b)  $V_R = 8\text{V}$ .

$$(a) V_{bi} = V_i \ln\left(\frac{N_a N_d}{n_i^2}\right) = (0.0259) \ln\left[\frac{(5 \times 10^{15})(5 \times 10^{16})}{(1.5 \times 10^{10})^2}\right] = 0.718 \text{ V}$$

$$x_n = \left\{ \frac{2\epsilon_s (V_{bi} + V_R)}{e} \left( \frac{N_a}{N_d} \right) \left( \frac{1}{N_a + N_d} \right) \right\}^{1/2}$$

$$= \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 4)}{1.6 \times 10^{-19}} \times \left( \frac{5 \times 10^{15}}{5 \times 10^{16}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2} = 1.054 \times 10^{-4} \text{ cm}$$

or  $x_n = 0.1054 \mu\text{m}$

$$x_p = \left\{ \frac{2\epsilon_s (V_{bi} + V_R)}{e} \left( \frac{N_d}{N_a} \right) \left( \frac{1}{N_a + N_d} \right) \right\}^{1/2}$$

$$= \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 4)}{1.6 \times 10^{-19}} \times \left( \frac{5 \times 10^{16}}{5 \times 10^{15}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2} = 1.054 \times 10^{-4} \text{ cm}$$

or  $x_p = 1.054 \mu\text{m}$

Ex 7.3 Si pn junction at 300K has  $N_d=5 \times 10^{16}/\text{cm}^3$  and  $N_a=5 \times 10^{15}/\text{cm}^3$ . Find  $V_{bi}$ ,  $x_n$ ,  $x_p$ , and  $W$  for reverse bias (a)  $V_R=4\text{V}$  & (b)  $V_R=8\text{V}$ . (cont'd)

$$W = \left[ \frac{2\epsilon_s (V_{bi} + V_R) \left( \frac{N_a + N_d}{N_a N_d} \right) \right]^{1/2}$$

$$= \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 4)}{1.6 \times 10^{-19}} \times \left[ \frac{5 \times 10^{15} + 5 \times 10^{16}}{(5 \times 10^{15})(5 \times 10^{16})} \right] \right]^{1/2} = 1.159 \times 10^{-4} \text{ cm}$$

or  $W = 1.159 \mu\text{m}$

(b)  $V_{bi} = 0.718 \text{ V}$

$$x_n = \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 8)}{1.6 \times 10^{-19}} \times \left( \frac{5 \times 10^{15}}{5 \times 10^{16}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2} = 1.432 \times 10^{-5} \text{ cm}$$

or  $x_n = 0.1432 \mu\text{m}$

$$x_p = \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 8)}{1.6 \times 10^{-19}} \times \left( \frac{5 \times 10^{16}}{5 \times 10^{15}} \right) \left( \frac{1}{5 \times 10^{15} + 5 \times 10^{16}} \right) \right]^{1/2} = 1.432 \times 10^{-4} \text{ cm}$$

or  $x_p = 1.432 \mu\text{m}$

$$W = \left[ \frac{2(11.7)(8.85 \times 10^{-14})(0.7184 + 8)}{1.6 \times 10^{-19}} \times \left[ \frac{5 \times 10^{15} + 5 \times 10^{16}}{(5 \times 10^{15})(5 \times 10^{16})} \right] \right]^{1/2} = 1.576 \times 10^{-4} \text{ cm}$$

or  $W = 1.576 \mu\text{m}$

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13

Ex 7.4  $|E_{\text{max}}|$  in a GaAs pn junction at 300K is limited to  $7.2 \times 10^4 \text{ V/cm}$  with  $N_d=5 \times 10^{15}/\text{cm}^3$  &  $N_a=3 \times 10^{16}/\text{cm}^3$ . Find max  $V_R$  that can be applied.

$$V_{bi} = V_T \ln \left( \frac{N_a N_d}{n_i^2} \right) = (0.0259) \ln \left[ \frac{(5 \times 10^{15})(3 \times 10^{16})}{(1.8 \times 10^6)^2} \right] = 1.173 \text{ V}$$

$$|E_{\text{max}}| = \left[ \frac{2\epsilon (V_{bi} + V_R) \left( \frac{N_a N_d}{N_a + N_d} \right) \right]^{1/2}$$

$$\text{Now } (7.2 \times 10^4)^2 = \left[ \frac{2(1.6 \times 10^{-19})(V_{bi} + V_R)}{(13.1)(8.85 \times 10^{-14})} \times \left[ \frac{(5 \times 10^{15})(3 \times 10^{16})}{5 \times 10^{15} + 3 \times 10^{16}} \right] \right]$$

$$5.184 \times 10^9 = 1.1829 \times 10^9 (V_{bi} + V_R)$$

$$V_{bi} + V_R = 1.173 + V_R = 4.382$$

$$\text{Then } V_R = 3.21 \text{ V}$$

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14

## Junction Capacitance: Depletion layer capacitance (also known as Transition Capacitance)

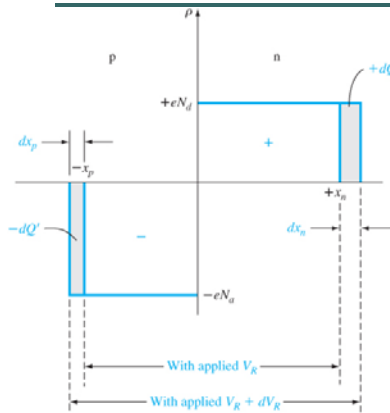


Figure 7.9 | Differential change in the space charge width with a differential change in reverse-biased voltage for a uniformly doped pn junction.

$$C' = \frac{dQ'}{dV_R}$$

where  $dQ' = eN_d dx_n = eN_d dx_p$

$$x_n = \sqrt{\frac{2\epsilon_s}{e} \cdot \frac{N_a}{N_d} \cdot \frac{1}{[N_a + N_d]} (V_{bi} + V_R)^{\frac{1}{2}}}$$

so  $C' = eN_d \frac{dx_n}{dV_R}$

$$= \frac{1}{2} eN_d \sqrt{\frac{2\epsilon_s}{e} \cdot \frac{N_a}{N_d} \cdot \frac{1}{[N_a + N_d]} (V_{bi} + V_R)^{-\frac{1}{2}}}$$

$$= \sqrt{\frac{e\epsilon_s}{2} \cdot \frac{N_a N_d}{[N_a + N_d]} (V_{bi} + V_R)^{-\frac{1}{2}}}$$

$$= \frac{\epsilon_s}{W}$$

Using  $x_p \Rightarrow$  the same result

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15

Ex 7.5 GaAs pn junction with  $N_a = 5 \times 10^{15}/\text{cm}^3$  &  $N_d = 2 \times 10^{16}/\text{cm}^3$  at 300K. (a) Calculate  $V_{bi}$ . (b) Find  $C'$  for  $V_R = 4\text{V}$ . (c) Find  $C'$  for  $V_R = 8\text{V}$ .

$$(a) V_{bi} = V_T \ln \left( \frac{N_a N_d}{n_i^2} \right) = (0.0259) \ln \left[ \frac{(2 \times 10^{16})(5 \times 10^{15})}{(1.8 \times 10^6)^2} \right] = 1.16\text{V}$$

$$(b) C' = \left[ \frac{e\epsilon_s N_a N_d}{2(V_{bi} + V_R)(N_a + N_d)} \right]^{1/2} = \left[ \frac{(1.6 \times 10^{-19})(13.1)(8.85 \times 10^{-14})}{2(1.162 + 4)} \times \frac{(5 \times 10^{15})(2 \times 10^{16})}{(5 \times 10^{15} + 2 \times 10^{16})} \right]^{1/2}$$

$$C' = 8.48 \times 10^{-9} \text{ F/cm}^2$$

$$(c) C' = \left[ \frac{(1.6 \times 10^{-19})(13.1)(8.85 \times 10^{-14})}{2(1.162 + 8)} \times \frac{(5 \times 10^{15})(2 \times 10^{16})}{(5 \times 10^{15} + 2 \times 10^{16})} \right]^{1/2}$$

$$C' = 6.36 \times 10^{-9} \text{ F/cm}^2$$

10/13/2012

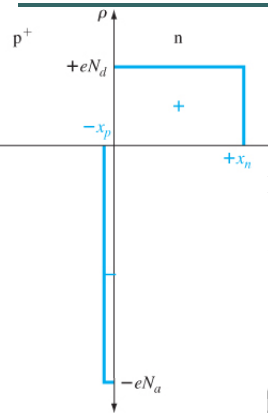
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16



## Single-sided junctions

(p<sup>+</sup>n for  $N_a \gg N_d$  (below), or pn<sup>+</sup> for  $N_a \ll N_d$ )



For  $N_a \gg N_d$  :

$$x_p \ll x_n \quad \& \quad W \approx x_n = \sqrt{\frac{2\epsilon_s(V_{bi} + V_R)}{eN_d}}$$

$$C' = \frac{\epsilon_s}{W} \approx \sqrt{\frac{e\epsilon_s N_d}{2(V_{bi} + V_R)}}$$

$$\left(\frac{1}{C'}\right)^2 = \frac{2(V_{bi} + V_R)}{e\epsilon_s N_d} \quad \text{which gives } N_d \text{ \& } V_{bi}$$

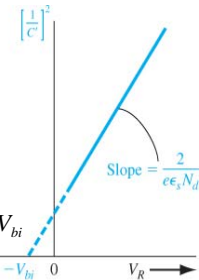


Figure 7.10 | Space charge density of a one-sided p<sup>+</sup>n junction.

Figure 7.11 |  $(1/C')^2$  versus  $V_R$  of a uniformly doped pn junction.

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Ex 7.6  $C'$  of a Si pn<sup>+</sup> junction with c/s area  $10^{-5}\text{cm}^2$  is  $0.105\text{pF}$  at  $300\text{K}$  and  $V_R=3\text{V}$ , and  $V_{bi}=0.765\text{V}$ . Find  $N_a$  &  $N_d$ .

$$\text{For a one-sided junction } C' = \left\{ \frac{e\epsilon_s N_d}{2(V_{bi} + V_R)} \right\}^{1/2}$$

$$C = A \cdot C' = (10^{-5}) C' = 0.105 \times 10^{-12} = (10^{-5}) \left\{ \frac{(1.6 \times 10^{-19})(11.7)(8.85 \times 10^{-14}) N_d}{2(3 + 0.765)} \right\}^{1/2}$$

$$(0.105 \times 10^{-12})^2 = (10^{-5})^2 (2.20 \times 10^{-32}) N_d$$

$$\text{So } N_d = 5.01 \times 10^{13} \text{ cm}^{-3}$$

$$\text{We have } V_{bi} = V_T \ln \left( \frac{N_a N_d}{n_i^2} \right)$$

$$\text{Then } N_a = \frac{n_i^2}{N_d} \exp \left( \frac{V_{bi}}{V_T} \right) = \frac{(1.5 \times 10^{10})^2}{5.01 \times 10^{13}} \exp \left( \frac{0.765}{0.0259} \right)$$

$$N_a = 3.02 \times 10^{17} \text{ cm}^{-3}$$

10/13/2012

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18

## (Reverse bias) Junction Breakdown

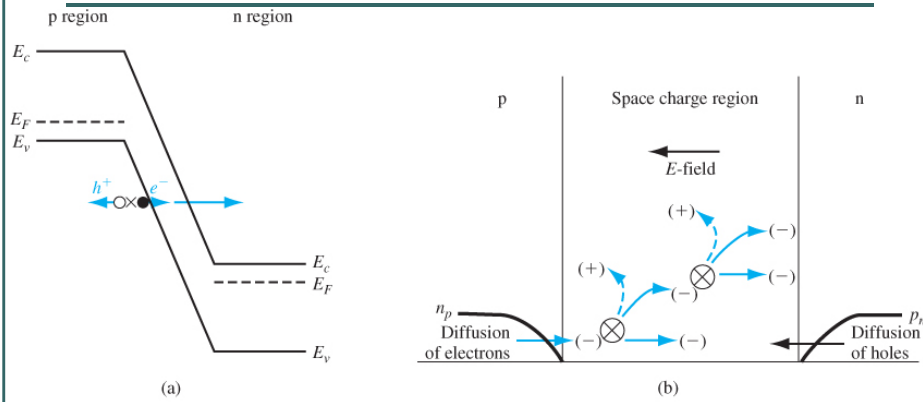


Figure 7.12 | (a) Zener breakdown mechanism in a reverse-biased pn junction; (b) avalanche breakdown process in a reverse-biased pn junction.

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19

## Avalanche

$$I_n(0) = I_{n0} \text{ \& } I_n(W) = M_n I_{n0}$$

( $M_n$  electron multiplication factor)

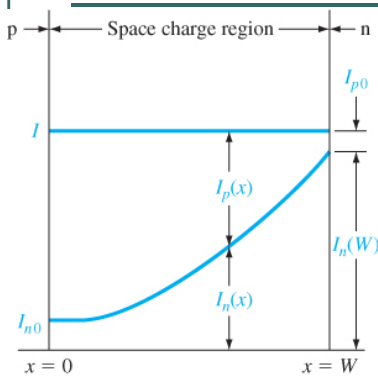


Figure 7.13 | Electron and hole current components through the space charge region during avalanche multiplication.

At point  $x$ ,  $dI_n(x) = [\alpha_n I_n(x) + \alpha_p I_p(x)]dx$ , where  $\alpha_n, \alpha_p$  = EHP ionization rates for electrons, holes

Total current  $I = I_n(x) + I_p(x) \Rightarrow I_p(x) = I - I_n(x)$

$$dI_n(x) = [\alpha_n I_n(x) + \alpha_p (I - I_n(x))]dx$$

$$= \alpha_p I + (\alpha_n - \alpha_p) I_n(x)$$

Simplify with  $\alpha_p \approx \alpha_n = \alpha \Rightarrow dI_n(x) = \alpha I$

$$\int_0^W dI_n(x) = \int_0^W \alpha I dx = I \int_0^W \alpha dx$$

$$= I_n(W) - I_n(0) = M_n I_{n0} - I_{n0} \approx I - I_{n0}$$

so  $\frac{I - I_{n0}}{I} = \int_0^W \alpha dx = 1 - \frac{1}{M_n}$

Avalanche when  $M_n \rightarrow \infty$ , i.e. when  $\int_0^W \alpha dx = 1$

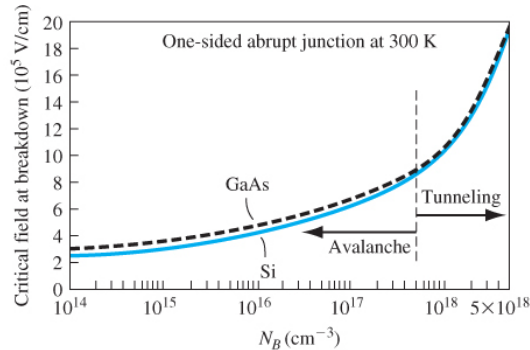
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20

# Avalanche & Zener breakdowns

$$\begin{aligned}
 \text{For } E_{\max} &= \frac{eN_d x_n}{\epsilon_s} \\
 &\approx \frac{eN_d}{\epsilon_s} \sqrt{\frac{2\epsilon_s}{eN_d} V_R} \\
 &= \sqrt{\frac{2eN_d}{\epsilon_s} V_R} \\
 \Rightarrow V_B &= \frac{\epsilon_s E_{\text{crit}}^2}{2eN_B} \\
 & \quad (N_B \text{ lower of } N_a, N_d)
 \end{aligned}$$



**Figure 7.14** | Critical electric field at breakdown in a one-sided junction as a function of impurity doping concentrations. (From Sze and Ng, [14].)

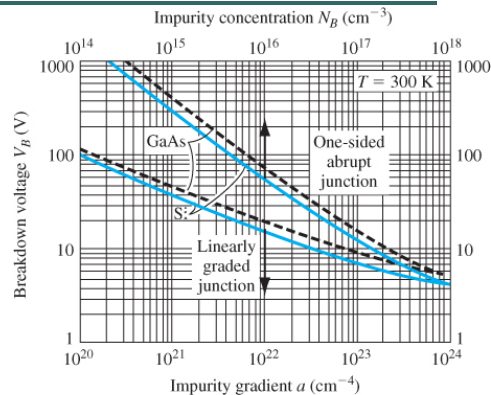
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Ex 7.7 Design single-sided, planar, uniformly doped Si planar diode for reverse breakdown V<sub>B</sub>=60V. What is max doping concentration on low-doped side to meet spec?

$$\begin{aligned}
 V_B &= \epsilon_s E_{\text{crit}}^2 / 2eN \\
 N &= \epsilon_s E_{\text{crit}}^2 / 2eV_B \\
 &= 11.7 \times 8.85 \times 10^{-12} (2 \times 10^7)^2 / 2 \times 1.6 \times 10^{-19} \times 60 \\
 & \quad \text{(from Fig 7.14 for light doping)} \\
 &= 2.16 \times 10^{21} / \text{m}^3 \\
 &= 2.16 \times 10^{15} / \text{cm}^3
 \end{aligned}$$

Iteration:  
E<sub>crit</sub> ≈ 3.5 × 10<sup>7</sup> V/m from Fig 7.14, so incr N & repeat

Compare Fig 7.15 N = 9 × 10<sup>15</sup> / cm<sup>3</sup>



**Figure 7.15** | Breakdown voltage versus impurity concentration in uniformly doped and linearly graded junctions. (From Sze [14].)

10/13/2012

ECE 415/515 J. E. Morris

22

## Linearly graded junction

**Figure 7.16** | Impurity concentrations of a pn junction with a nonuniformly doped p region.

**Figure 7.17** | Space charge density in a linearly graded pn junction.

$$\frac{dE}{dx} = \frac{\rho(x)}{\epsilon_s} = \frac{eax}{\epsilon_s} \text{ where } a \text{ defines gradient}$$

$$\therefore E(x) = \int \frac{eax}{\epsilon_s} dx = \frac{eax^2}{2\epsilon_s} + A \rightarrow 0 \text{ at } x = \pm x_0,$$


---


$$\text{so } E(x) = \frac{ea(x^2 - x_0^2)}{2\epsilon_s}$$

$$E_{\max} \text{ when } \frac{dE(x)}{dx} = 0 \text{ at } x = 0, E_{\max} = -\frac{eax_0^2}{2\epsilon_s}$$

$$\phi(x) = -\int E dx = -\frac{ea(x^3/3 - x_0^2 x)}{2\epsilon_s} + B$$

$$\text{Define } \phi(-x_0) = 0, B = +\frac{eax_0^3}{3\epsilon_s} \Rightarrow \phi(x) = -\int E dx$$

$$= -\frac{ea(x^3 - 3x_0^2 x - 2x_0^3)}{6\epsilon_s} \Rightarrow V_{bi} = \phi(+x_0) = \frac{2}{3} \frac{eax_0^3}{\epsilon_s}$$

$$\text{so } x_0 = \left[ \frac{3}{2} \frac{\epsilon_s}{ea} (V_{bi} + V_R) \right]^{1/3}$$

$$\text{As before } V_{bi} = \frac{kT}{e} \ln \left[ \frac{N_d(x_0)N_a(-x_0)}{n_i^2} \right]$$

$$\text{where } N_d(x_0) = ax_0 = N_a(-x_0), \text{ so } V_{bi} = \frac{kT}{e} \ln[ax_0/n_i]^2$$

## Linear junction capacitance

**Figure 7.18** | Differential change in space charge width with a differential change in reverse-biased voltage for a linearly graded pn junction.

$$+dQ' = \rho(x_0) dx_0 = eax_0 dx_0$$

$$x_0 = \left[ \frac{3}{2} \frac{\epsilon_s}{ea} (V_{bi} + V_R) \right]^{1/3}$$

$$C' = \frac{dQ'}{dV_R} = (eax_0) \frac{dx_0}{dV_R}$$

$$\text{and from } x_0 = \left[ \frac{3\epsilon_s}{2ea} (V_{bi} + V_R) \right]^{1/3}$$

$$C' = (ea) \left[ \frac{3\epsilon_s}{2ea} (V_{bi} + V_R) \right]^{1/3} \left[ \frac{3\epsilon_s}{2ea} \right]^{1/3} \frac{1}{3} (V_{bi} + V_R)^{-2/3}$$

$$= \left[ \frac{ea\epsilon_s^2}{12(V_{bi} + V_R)} \right]^{1/3}$$

# Hyperabrupt junctions

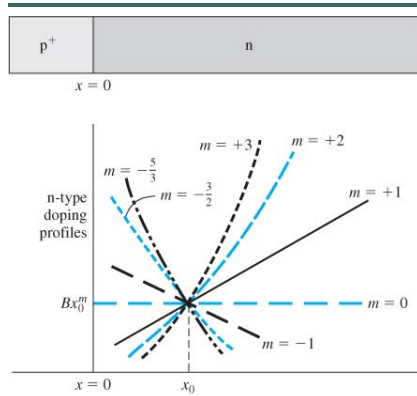


Figure 7.19 | Generalized doping profiles of a one-sided p<sup>+</sup>n junction. (From Sze [14].)

Doping for  $x > 0$ :  $N = Bx^m$   
 ("Hyperabrupt" if  $m < 0$ )

It can be shown that

$$C^I = \left[ \frac{eB\epsilon_s^{m+1}}{(m+2)(V_{bi} + V_R)} \right]^{\frac{1}{m+2}}$$

$$= C_0 (V_{bi} + V_R)^{\frac{1}{m+2}}$$

If used for tuning  $f_r = (2\pi\sqrt{LC})^{-1}$

For  $f_r \propto V_R$

need  $f_r \propto C^{\frac{1}{2}} \propto V_R^{\left(-\frac{1}{m+2}\right)\left(\frac{1}{2}\right)} \propto V_R$

i.e.  $\frac{1}{m+2} \cdot \frac{1}{2} = 1, \quad m = -\frac{3}{2}$